

Notice of References Cited	Application/Control No. 10/603,830	Applicant(s)/Patent Under Reexamination ENDO, SATOSHI	
	Examiner Linh T. Nguyen	Art Unit 2627	Page 1 of 1

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*	B	US-6,016,295	01-2000	Endoh et al.	369/47.16
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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